Search Notes

Application/Control No.	Applicant(s)/Pate Reexamination	Applicant(s)/Patent under Reexamination	
10/551,215	KANG, DOEK-MAN		
Examiner	Art Unit		
John S. Chu	1795		

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST SEARCH IN FILE	1. (07	zse		